



Search Notes 	Application/Control No. 09116124	Applicant(s)/Patent Under Reexamination NISHINA ET AL.
	Examiner Tran, Hai	Art Unit 2623


Notes	Date	Examiner
EAST TEXT SEARCH ATTACHED; Son Huynh (725); Rueben Brown (725)	10/16/2006	HVT
William Bashore (715)	9/21/2006	HVT
U.S. Patent and Trademark Office		Part of Paper No.: 20061016

<i>Interference Searched</i> 	Application/Control No. 09116124	Applicant(s)/Patent Under Reexamination NISHINA ET AL.
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Class	SubClass	Date	Examiner
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Interference searched attached	10/16/2006	HVT
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UPDATE SEARCH

10/16/2006

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